### Recitation Class 6

Zexi Li

lzx12138@sjtu.edu.cn

2021.06.29

#### Outline

Chapter 7-II The pn Junction

Chapter 8-I The pn Junction Diode

#### Table of Contents

Chapter 7-II The pn Junction

Chapter 8-I The pn Junction Diode

# Reverse Applied Bias

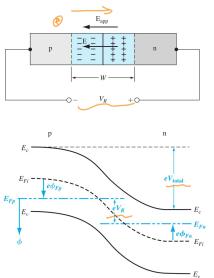


Figure: Energy-band diagram

### From RC 5

$$N_{a}x_{p} = N_{d}x_{n}$$

$$x_{n} = \sqrt{\frac{2\varepsilon_{s}(V_{bi} + V_{R})}{e} \left[\frac{N_{a}}{N_{d}}\right] \left[\frac{1}{N_{a} + N_{d}}\right]}$$

$$x_{p} = \sqrt{\frac{2\varepsilon_{s}(V_{bi} + V_{R})}{e} \left[\frac{N_{d}}{N_{a}}\right] \left[\frac{1}{N_{a} + N_{d}}\right]}$$

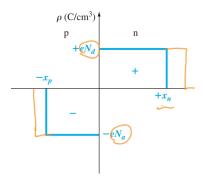
 $\varepsilon_s = \varepsilon_r \varepsilon_0$ , where  $\varepsilon_0 = 8.85 \times 10^{-14} F \cdot cm^{-1}$ .  $\varepsilon_r = 11.7$  for Si.

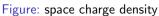
$$W = x_n + x_p = \sqrt{\frac{2\varepsilon_s (V_{bi} + V_R)}{e} \left[\frac{N_a + N_d}{N_a N_d}\right]}$$

#### From RC 5

$$E = \begin{cases} -\frac{eN_a}{\varepsilon_s}(x + x_p), & -x_p \le x \le 0 \\ \frac{eN_d}{\varepsilon_s}(x_n - x), & 0 \le x \le x_n \end{cases}$$
$$|E_{max}| = -\frac{eN_dx_n}{\varepsilon_s} = -\frac{eN_ax_p}{\varepsilon_s}$$
$$= -\frac{2(V_{bi} + V_R)}{W}$$
$$\phi(x) = -\int E(x) \, \mathrm{d}x$$

### From RC 5





$$N_a x_p = N_d x_n$$

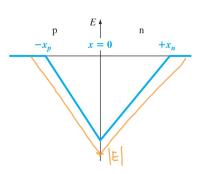


Figure: electric field

$$|k| = rac{eN_{a/d}}{arepsilon_s}$$

### Junction Capacitance

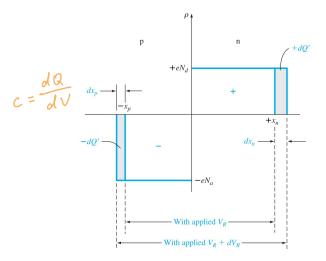


Figure: Differential change in the space charge width with a differential change in reverse-biased voltage for a uniformly doped pn junction

# Junction Capacitance

$$\frac{C}{dV_R} = \frac{dQV}{dV_R}$$

$$C = A C$$

$$dQ' = eN_d dx_n = eN_a dx_p$$

dQ' has units of  $C/cm^2$ , and C' has units of  $F/cm^2$ .

$$C' = \sqrt{\frac{e\varepsilon_s N_a N_d}{2(V_{bi} + V_R)(N_a + N_d)}} = \frac{\varepsilon_s}{W}$$

#### One-sided Junction

$$p^+ n$$
 junction,  $N_a \gg N_d$ .  $X_p \ll X_n$   $W \approx X_n$   $C' \approx \sqrt{\frac{e \varepsilon_s N_d}{2(V_{bi} + V_R)}}$ 

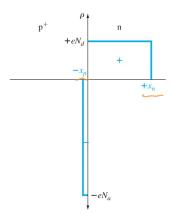


Figure: Space charge density of a one-sided p<sup>+</sup>n junction.

#### One-sided Junciton

$$C' \approx \sqrt{\frac{e\varepsilon_s N_d}{2(V_{bi} + V_R)}}$$

$$\Rightarrow \left(\frac{1}{C'}\right)^2 = \frac{2(V_{bi} + V_R)}{e\varepsilon_s N_d}$$

Experimentally determine  $V_{bi}$  and  $N_d$ .

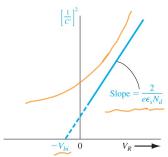


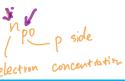
Figure:  $(1/C')^2$  versus  $V_R$  of a uniformly doped pn junction

#### Table of Contents

Chapter 7-II The pn Junction

Chapter 8-I The pn Junction Diode

### **Notations**



Гегт	Meaning
$V_a$	Acceptor concentration in the p region of the pn junction
$V_d$	Donor concentration in the n region of the pn junction
$n_{n0} = N_d$	Thermal-equilibrium majority carrier electron concentration in the n region
	Thermal-equilibrium majority carrier hole concentration in the p regio
	Thermal-equilibrium minority carrier electron concentration in the p region
$\rho_{n0}=n_i^2/N_d$	Thermal-equilibrium minority carrier hole concentration in the n regio Total minority carrier electron concentration in the p region
p n	Total minority carrier hole concentration in the n region
$a_p(-x_p)$	Minority carrier electron concentration in the p region at the space charge edge
$o_n(x_n)$	Minority carrier hole concentration in the n region at the space charge edge
$\delta n_p = n_p - n_{p0}$	Excess minority carrier electron concentration in the p region
$\hat{p}_n = p_n - p_{n0}$	Excess minority carrier hole concentration in the n region

### Ideal Current-Voltage Relationship

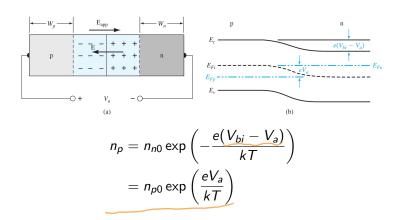
- The abrupt depletion layer approximation applies. The space charge regions have abrupt boundaries, and the semiconductor is neutral outside of the depletion region.
- The Maxwell–Boltzmann approximation applies to carrier statistics.
- 3. The concepts of low injection and complete ionization apply.
- a) The total current is a constant throughout the entire pn structure.
  - b) The individual electron and hole currents are continuous functions through the pn structure.
  - c) The individual electron and hole currents are constant throughout the depletion region.

#### Concentration Relation on Two Sides

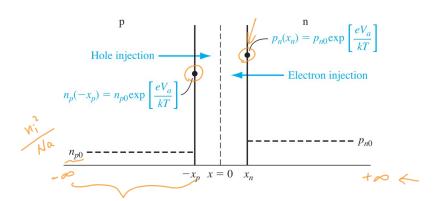
$$\begin{cases} V_{bi} = V_t \ln \left( \frac{N_a N_d}{n_i^2} \right) \\ n_{n0} \approx N_d \\ n_{p0} \approx \frac{n_i^2}{N_a} \\ \implies \underbrace{n_{p0}} = \underbrace{n_{n0}} \exp \left( -\frac{eV_{bi}}{kT} \right) \end{cases}$$

Relates the minority carrier electron concentration on the p side of the junction to the majority carrier electron concentration on the n side of the junction in thermal equilibrium.

#### Forward Biased



#### Forward Biased



## Minority Carrier Distribution

$$D_{p} \frac{\mathrm{d}^{2}(\delta p_{n})}{\mathrm{d}x^{2}} - \mu_{p} \left( E \frac{\mathrm{d}(\delta p_{n})}{\mathrm{d}x} + p \frac{\mathrm{d}E}{\mathrm{d}x} \right) + g' - \frac{\delta p_{n}}{\tau_{pt}} = 0$$

Assumption: the electric field is zero in both the neutral p and n regions.

In n region for  $x > x_n$ , we have g' = 0.

The equation becomes

$$\frac{\mathrm{d}^2(\delta p_n)}{\mathrm{d}x^2} - \frac{\delta p_n}{L_p^2} = 0, \quad (x > x_n), \quad L_n^2 = D_n \tau_{n0}$$

Solve it with boundary conditions

$$p_n(x_n) = p_{n0} \exp\left(\frac{eV_a}{kT}\right)$$
  
 $p_n(x \to +\infty) = p_{n0}$ 

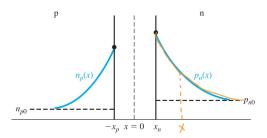
## Minority Carrier Distribution - Continue

The solution is

$$\delta p_n(x) = p_n(x) - p_{n0} = p_{n0} \left[ \exp\left(\frac{eV_a}{kT}\right) - 1 \right] \exp\left(\frac{x_n - x}{L_p}\right), \quad x \ge x_n$$

Similarly,

$$\delta n_p(x) = n_p(x) - n_{p0} = n_{p0} \left[ \exp\left(\frac{eV_a}{kT}\right) - 1 \right] \exp\left(\frac{x_p + x}{L_n}\right), \quad x \le -x_p$$



### Quasi-Fermi Level

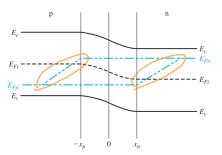


Figure: Quasi-Fermi levels through a forward-biased pn junction.

In Chapter 6 there are equations

$$p = p_0 + \delta p = n_i \exp\left(\frac{E_{Fi} - E_{Fp}}{kT}\right)$$

Therefore the quasi-Fermi levels are linear functions of distance in the neutral p and n regions as shown in the Figure.

### Quasi-Fermi Level - Continue

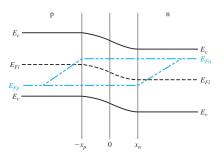


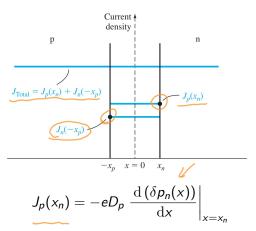
Figure: Quasi-Fermi levels through a forward-biased pn junction.

Also,

$$np = n_i^2 \exp\left(\frac{E_{Fn} - E_{Fp}}{kT}\right)$$

### Ideal pn Junction Current

Assumption 4(a): The total current is a constant throughout the entire pn structure.



## Ideal pn Junction Current - Continue

$$J_{p}(x_{n}) = \frac{eD_{p}p_{n0}}{L_{p}} \left[ \exp\left(\frac{eV_{a}}{kT}\right) - 1 \right]$$

$$J_{n}(-x_{p}) = \frac{eD_{n}n_{p0}}{L_{n}} \left[ \exp\left(\frac{eV_{a}}{kT}\right) - 1 \right]$$

Then the total current density

$$J = J_{s} \left[ \exp\left(\frac{eV_{a}}{kT}\right) - 1 \right]$$
where  $J_{s} = \left[\frac{eD_{p}p_{n0}}{L_{p}} + \frac{eD_{n}n_{p0}}{L_{n}}\right]$ 

### Ideal pn Junction Current - Continue

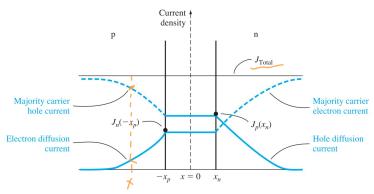


Figure: Idea electron and hole current components through a pn junction under forward bias.

### Example

Consider the following parameters in a silicon pn junction at T=300K:

$$N_a = N_d = 10^{16} cm^{-3}$$
  $n_i = 1.5 \times 10^{10} cm^{-3}$   
 $D_n = 25 cm^2/s$   $\tau_{p0} = \tau_{n0} = 5 \times 10^{-7} s$   
 $D_p = 10 cm^2/s$   $\varepsilon_r = 11.7$ 

- a) Determine the ideal reverse-saturation current density.
- b) Calculate the electric field in a neutral region of a silicon diode to produce a given majority carrier drift current density.

(Textbook Example 8.2 & 8.4)

#### Solution

#### Solution:

b)
----

#### Comment:

- a) The ideal reverse-biased saturation current density is very small.
- b) We assumed, in the derivation of the current-voltage equation, that the electric field in the neutral p and n regions was zero. Although the electric field is not zero, this example shows that the magnitude is very small—thus the approximation of zero electric field is very good.

# End